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Attorney Docket No. 0553-0200.01

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Re Application of:

Shunpei YAMAZAKI et al

Serial No.: 10/664,615

Filed: September 19, 2003

Art Unit: 2823

Examiner: Khiem D. Nguyen

For: SEMICONDUCTOR DEVICE AND
MANUFACTURING METHOD THEREOF

CERTIFICATE OF TRANSMISSION

I hereby certify that this correspondence is being sent
by facsimile to the Commissioner for Patents

& by mail Date June 1, 2005

Fax Number (571) 273 0025

Cristine M. Noll

Print or Type Name of Person

Signature

Cristine M. Noll

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Pursuant to 37 C.F.R. §1.97, as revised on February 4, 1992, 1135 OG 23-24, Applicant hereby calls the Examiner's attention to documents listed on the attached form, which documents may be material to the examination of this application. As this application was filed after June 30, 2003, pursuant to 37 CFR §1.491(b), copies of cited US patent and US patent application publications are not submitted herewith. Copies of foreign patent documents and non-patent literature documents are enclosed herewith for the Examiner's consideration.

No inference should be drawn that the attached list sets forth a comprehensive investigation of the prior art, that any or all are

pertinent to the invention, or that any apparatus disclosed is equivalent to the subject invention.

The citation of the above-discussed documents is not to be construed as an assertion that more pertinent art could not possibly be in existence. Citation of any document herein is not to be construed as an admission that any subject matter disclosed in the document is necessarily within the inventive field of endeavor, that any disclosure is necessarily prior in time to a particular date which may be relevant to the instant patent application, and/or that any disclosure is otherwise necessarily prior art with respect to the instant invention.

Applicant also respectfully reserves the right to later set forth how the instant invention is distinguished over the disclosure of any document or other art, including the disclosure of those documents discussed herein, that may be cited by the Examiner in rejecting a claim in the instant patent application.

As a RCE is being filed herewith via facsimile to the Office of Petitions, (and courtesy copy of the IDS with references by mail) no fee is believed necessary for this IDS. However, if a fee is required, please charge Deposit Account No. 50/1039.



Respectfully submitted,



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LIST OF PUBLICATIONS CITED BY APPLICANT			<u>Atty. Docket No.</u> 0553-0200.01		<u>Serial No.</u> 10/664,615	
			<u>Applicant</u> Shunpei YAMAZAKI et al			
			<u>Filing Date</u> September 19, 2003		<u>Group</u> 2823	
US PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	4,851,363	07/25/89	Troxell et al	437	40	03/21/88
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	5,401,982	03/28/95	King et al	257	59	03/03/94
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	DOCUMENT NUMBER	DATE	APPLICANT	English Abstract	English Trans.	FILING DATE
	EP 0 588 370 A2	03/23/94	Matsushita Electric Ind. Co., Ltd.			09/20/93
	EP 0 738 012 A2	10/16/96	Canon Kabushiki Kaisha			04/10/96
	EP 0 589 478 B1	11/17/99	Sony Corporation			09/24/93
	EP 1 003 223 A2	05/24/00	Semiconductor Energy Lab Co. Ltd.			11/16/99
	EP 1 049 167 A2	11/02/00	Semiconductor Energy Lab Co. Ltd.			04/27/00

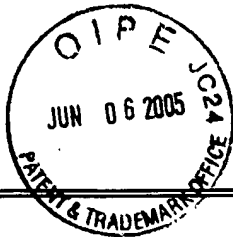
OTHER PRIOR ART - NON-PATENT LITERATURE DOCUMENTS
(Including Author, Title, Date, Pertinent Pages)

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DATE CONSIDERED:

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP form. Draw line through citation if not in conformance and not considered. Include a copy of this form with the next communication to applicant.



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	<u>Applicant</u> Shunpei YAMAZAKI et al	
	<u>Filing Date</u> September 19, 2003	<u>Group</u> 2823

US PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	6,773,971 B1 US 2004/ 0192004 A1	08/10/04 09/30/04	Zhang et al Yamazaki et al	438 438	163 321	09/03/97 05/18/04

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